

SN54HCT563, SN74HCT563  
**OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS**

D2804, MARCH 1984—REVISED SEPTEMBER 1987

- Inputs are TTL-Voltage Compatible
- High-Current 3-State Output Drive Bus-Lines Directly or Up to 15 LSTTL Loads
- Bus-Structured Pinout
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

**description**

These 8-bit latches feature three-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

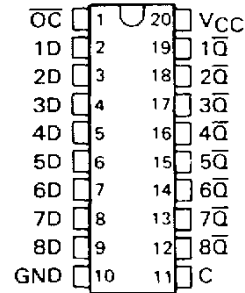
The eight latches are transparent D-type latches. While the enable (C) is high the  $\bar{Q}$  outputs will follow the complement of data (D) inputs. When the enable is taken low the outputs will be latched at the inverses of the levels that were set up at the D inputs.

An output-control ( $\overline{OC}$ ) input can be used to place the eight outputs in either a normal logic state (high or low levels) or a high-impedance state. In the high-impedance state the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased high-logic level provide the capability to drive the bus lines in a bus-organized system without need for interface or pull-up components.

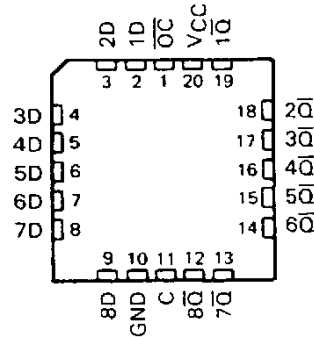
The output control ( $\overline{OC}$ ) does not affect the internal operation of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54HCT563 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74HCT563 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

SN54HCT563 . . . J PACKAGE  
 SN74HCT563 . . . DW OR N PACKAGE  
 (TOP VIEW)



SN54HCT563 . . . FK PACKAGE  
 (TOP VIEW)



**FUNCTION TABLE**

INPUTS			OUTPUT $\bar{Q}$
ENABLE			
$\overline{OC}$	C	D	
L	H	H	L
L	H	L	H
L	L	X	$\bar{Q}_0$
H	X	X	Z

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

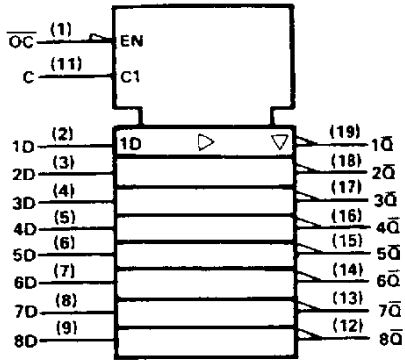


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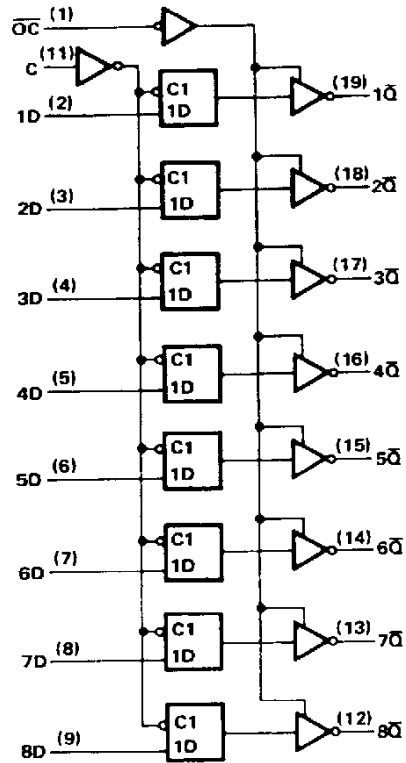
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logic symbol†



†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



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**OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS**

**absolute maximum ratings over operating free-air temperature †**

Supply voltage range, $V_{CC}$ .....	-0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) .....	$\pm 20$ mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) .....	$\pm 20$ mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ ) .....	$\pm 35$ mA
Continuous current through $V_{CC}$ or GND pins .....	$\pm 70$ mA
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package .....	300°C
Lead temperature 1,6 mm (1/16 in) from case for 10 s: DW or N package .....	260°C
Storage temperature range .....	$\sim 65^\circ\text{C}$ to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

**recommended operating conditions**

		SN54HCT563			SN74HCT563			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX		
$V_{CC}$	Supply voltage	4.5	5	5.5	4.5	5	5.5	V	
$V_{IH}$	High-level input voltage	$V_{CC} = 4.5$ V to 5.5 V		2	2			V	
$V_{IL}$	Low-level input voltage	$V_{CC} = 4.5$ V to 5.5 V		0	0.8			V	
$V_I$	Input voltage	0		$V_{CC}$		0		$V_{CC}$	V
$V_O$	Output voltage	0		$V_{CC}$		0		$V_{CC}$	V
$t_t$	Input transition (rise and fall) times	0		500		0		500	ns
$T_A$	Operating free-air temperature	-55		125		-40		85	°C

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	$V_{CC}$	$T_A = 25^\circ\text{C}$			SN54HCT563		SN74HCT563		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$V_{OH}$	$V_I = V_{IH}$ or $V_{IL}$ , $I_{OH} = -20 \mu\text{A}$	4.5 V	4.4	4.499		4.4		4.4	V	
	$V_I = V_{IH}$ or $V_{IL}$ , $I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.30		3.7		3.84		
$V_{OL}$	$V_I = V_{IH}$ or $V_{IL}$ , $I_{OL} = 20 \mu\text{A}$	4.5 V		0.001	0.1		0.1	0.1	V	
	$V_I = V_{IH}$ or $V_{IL}$ , $I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4	0.33		
$I_I$	$V_I = V_{CC}$ or 0	5.5 V		$\pm 0.1$	$\pm 100$		$\pm 1000$	$\pm 1000$	nA	
$I_{OZ}$	$V_O = V_{CC}$ or 0	5.5 V		$\pm 0.01$	$\pm 0.5$		$\pm 10$	$\pm 5$	$\mu\text{A}$	
$I_{CC}$	$V_I = V_{CC}$ or 0, $I_O = 0$	5.5 V			8		160	80	$\mu\text{A}$	
$\Delta I_{CC}^\ddagger$	One input at 0.5 V or 2.4 V Other inputs at 0 V or $V_{CC}$	5.5 V		1.4	2.4		3	2.9	mA	
$C_I$		4.5 to 5.5 V		3	10		10	10	pF	

‡ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V to  $V_{CC}$ .

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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

	V <sub>CC</sub>	T <sub>A</sub> = 25°C		SN54HCT563		SN74HCT563		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>w</sub> Pulse duration, enable C high	4.5 V 5.5 V	20 17		30 27		25 23		ns
t <sub>su</sub> Setup time, data before enable C↓	4.5 V 5.5 V	10 9		15 14		13 12		ns
t <sub>h</sub> Hold time, data after enable C↓	4.5 V 5.5 V	5 5		5 5		5 5		ns

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), C<sub>L</sub> = 50 pF (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub>	T <sub>A</sub> = 25°C			SN54HCT563		SN74HCT563		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	D	$\bar{Q}$	4.5 V		28	35		53		44	ns
			5.5 V		24	32		48		40	
t <sub>pd</sub>	C	Any $\bar{Q}$	4.5 V		30	35		53		44	ns
			5.5 V		28	32		48		40	
t <sub>en</sub>	$\overline{OC}$	Any $\bar{Q}$	4.5 V		28	35		53		44	ns
			5.5 V		25	32		48		40	
t <sub>dis</sub>	$\overline{OC}$	Any $\bar{Q}$	4.5 V		25	35		53		44	ns
			5.5 V		24	32		48		40	
t <sub>t</sub>		Any $\bar{Q}$	4.5 V		10	12		18		15	ns
			5.5 V		9	11		16		14	

C <sub>pd</sub>	Power dissipation capacitance per latch	No load, T <sub>A</sub> = 25°C	50 pF typ
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switching characteristics over recommended operating free-air temperature range (unless otherwise noted), C<sub>L</sub> = 150 pF (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub>	T <sub>A</sub> = 25°C			SN54HCT563		SN74HCT563		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	D	$\bar{Q}$	4.5 V		36	52		79		65	ns
			5.5 V		32	47		71		59	
t <sub>pd</sub>	C	Any $\bar{Q}$	4.5 V		40	52		79		65	ns
			5.5 V		38	47		71		59	
t <sub>en</sub>	$\overline{OC}$	Any $\bar{Q}$	4.5 V		35	52		79		65	ns
			5.5 V		29	47		71		59	
t <sub>t</sub>		Any $\bar{Q}$	4.5 V		18	42		63		53	ns
			5.5 V		16	38		57		48	

Note 1: Load circuits and voltage waveforms are shown in Section 1.



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